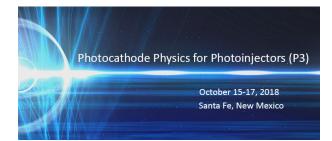
Photocathode Physics for Photoinjectors 2018



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Engineered Nanodiamond Photocathodes

Monday, 15 October 2018 11:00 (15 minutes)

n-type ultra-nano-crystalline diamond (n-UNCD, a synthetic polycrystalline, a mix of sp3 and sp2 phases, diamond

with semimetallic electron conductivity) has emerged as a negative electron a±nity (NEA) photocathode platform

that can be engineered toward a speci⁻c targeted application. This presentation summarizes our experimental results

related to (i) quantum e±ciency (QE); (ii) ruggedness/lifetime; (iii) emittance/mean transverse energy (MTE); (iv)

time response of n-UNCD photocathode structures.

NEA can be induced on UNCD via surface treatment in hydrogen. Such NEA is stable against air exposure for

extended time. The combination of air resistant NEA and n-doping is the key to engineer low work function. Nitrogen-

doped UNCD, (N)UNCD, processed in H2 plasma demonstrated QE »0.1% at 254 nm and enhanced photoelectric

response at wavelengths up to 400 nm. Recently, it was experimentally established that submicron (N)UNCD pho-

tocathodes feature optical interference. This e®ect suggests strong optical density enhancement on the photocathode

surface and minimized delay in photoelectron emission (potentially prompt response time) and points out a °exible

path to engineer optical response window of the photocathode to further enhance QE.

Lastly, we measured MTE of a (N)UNCD cathode that was found to be .250 meV with weak dependence on the

photon energy. We will outline a concept that link together our experimental results with the graphitic patch model

according to which electrons in UNCD are emitted from sp2 graphitic grain boundaries, implying that the e®ective

mass of emitted electrons is $\frac{1}{11}$ of the free electron mass and explaining weak MTE dependence on the excess

energy of the primary photons. This fact together with nanometer surface roughness could pave a way to a small

intrinsic emittance.

Presenter: BARYSHEV, Sergey (ECE / Michigan State University)

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